Notice of References Cited Application/Control No. 10/675,007 Examiner SHARAD RAMPURIA Applicant(s)/Patent Under Reexamination JEYASEELAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0039817 A1	02-2004	Lee et al.	709/225
*	В	US-7,440,756 B1	10-2008	Wang et al.	455/436
*	C	US-6,668,167 B2	12-2003	McDowell et al.	455/412.1
*	D	US-7,633,915 B1	12-2009	Lewis, Ronald E.	370/338
*	Е	US-7,738,876 B1	06-2010	Radhakrishnan et al.	455/450
*	F	US-7,706,790 B2	04-2010	Dunn et al.	455/434
*	G	US-7,406,319 B2	07-2008	Kostic et al.	455/453
*	Ι	US-2010/0136969 A1	06-2010	Nader et al.	455/434
*	I	US-5,432,841 A	07-1995	Rimer, Neil A.	455/457
*	J	US-2010/0110890 A1	05-2010	Rainer et al.	370/232
*	K	US-2005/0070275 A1	03-2005	Jeyaseelan et al.	455/432.1
*	L	US-5,152,009 A	09-1992	Sato, Kazuyoshi	455/134
*	М	US-2005/0148328 A1	07-2005	Pathan et al.	455/432.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.